

Vishay Siliconix

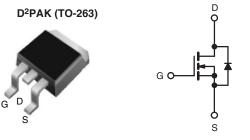
RoHS'

HALOGEN

**FREE** 

## **Power MOSFET**

| PRODUCT SUMMARY                            |                        |       |  |  |  |
|--|------------------------|-------|--|--|--|
| V <sub>DS</sub> at T <sub>J</sub> max. (V) | 650                    |       |  |  |  |
| R <sub>DS(on)</sub> (Ω)                    | V <sub>GS</sub> = 10 V | 0.190 |  |  |  |
| Q <sub>g</sub> (Max.) (nC)                 | 98                     |       |  |  |  |
| Q <sub>gs</sub> (nC)                       | 17                     |       |  |  |  |
| Q <sub>gd</sub> (nC)                       | 25                     |       |  |  |  |
| Configuration                              | Single                 |       |  |  |  |



N-Channel MOSFET

#### **FEATURES**

- Halogen-free According to IEC 61249-2-21 Definition
- High E<sub>AR</sub> Capability
- Lower Figure-of-Merit Ron x Qg
- 100 % Avalanche Tested
- High Peak Current Capability
- dV/dt Ruggedness
- Effective Coss Specified
- Improved Transconductance
- Improved t<sub>rr</sub>/Q<sub>rr</sub>
- Improved Gate Charge
- High Power Dissipation Capability
- Compliant to RoHS Directive 2002/95/EC

| ORDERING INFORMATION            |                             |  |  |  |
|---------------------------------|-----------------------------|--|--|--|
| Package                         | D <sup>2</sup> PAK (TO-263) |  |  |  |
| Lead (Pb)-free and Halogen-free | SiHB22N60S-GE3              |  |  |  |
| Lead (Pb)-free                  | SiHB22N60S-E3               |  |  |  |

| ABSOLUTE MAXIMUM RATINGS ( $T_C$ :               | = 25 °C, unl                      | ess otherwis                   | se noted)                         |               |         |  |
|--|-----------------------------------|--------------------------------|-----------------------------------|---------------|---------|--|
| PARAMETER  | SYMBOL                            | LIMIT                          | UNIT                              |               |         |  |
| Drain-Source Voltage                             |                                   |                                | V <sub>DS</sub>                   | 600           | V       |  |
| Gate-Source Voltage                              |                                   |                                | $V_{GS}$                          | ± 20          | \ \ \ \ |  |
| Continuous Drain Current <sup>a</sup>            | V <sub>GS</sub> at 10 V           | T <sub>C</sub> = 25 °C         | - I <sub>D</sub>                  | 22            |         |  |
|  |                                   | T <sub>C</sub> = 100 °C        |                                   | 13            | Α       |  |
| Ised Drain Current <sup>b</sup>                  |                                   |                                | I <sub>DM</sub>                   | 65            |         |  |
| Linear Derating Factor                           |                                   | D <sup>2</sup> PAK<br>(TO-263) |                                   | 2             | W/°C    |  |
| Single Pulse Avalanche Energy <sup>c</sup>       |                                   |                                | E <sub>AS</sub>                   | 690           | - mJ    |  |
| Repetitive Avalanche Energy <sup>b</sup>         | ive Avalanche Energy <sup>b</sup> |                                |                                   | 25            |         |  |
| Maximum Power Dissipation                        |                                   | D <sup>2</sup> PAK<br>(TO-263) | P <sub>D</sub>                    | 250           | W       |  |
| Peak Diode Recovery dV/dt <sup>d</sup>           |                                   |                                | dV/dt                             | 7.3           | V/ns    |  |
| Operating Junction and Storage Temperature Range |                                   |                                | T <sub>J</sub> , T <sub>stg</sub> | - 55 to + 150 |         |  |
| Soldering Recommendations (Peak Temperature)e    | for 10 s                          |                                | -                                 | 300           | °C      |  |

#### Notes

- a. Limited by maximum junction temperature.
- b. Repetitive rating; pulse width limited by maximum junction temperature.
- c.  $V_{DD}$  = 50 V, starting  $T_J$  = 25 °C, L = 28.2 mH,  $R_g$  = 25  $\Omega$ ,  $I_{AS}$  = 7 A.
- d.  $I_{SD} \le 22$  A,  $dI/dt \le 340$  A/ $\mu$ s,  $V_{DD} \le V_{DS}$ ,  $T_J \le 150$  °C.
- e. 1.6 mm from case.

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply

# SiHB22N60S

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| THERMAL RESISTANCE RATINGS       |                             |            |      |      |      |  |
|----------------------------------|-----------------------------|------------|------|------|------|--|
| PARAMETER                        |                             | SYMBOL     | TYP. | MAX. | UNIT |  |
| Maximum Junction-to-Ambient      | D <sup>2</sup> PAK (TO-263) | $R_{thJA}$ | -    | 62   | °C/W |  |
| Maximum Junction-to-Case (Drain) | D <sup>2</sup> PAK (TO-263) | $R_{thJC}$ | -    | 0.5  |      |  |

| PARAMETER                                     | SYMBOL                                  | TES  | MIN.                           | TYP. | MAX.     | UNIT  |     |
|---|---|--|--------------------------------|------|----------|-------|-----|
| Static  |   |  |                                | •    |          | •     |     |
| Drain-Source Breakdown Voltage                | V <sub>DS</sub>                         | V <sub>GS</sub> = 0 V, I <sub>D</sub> = 1 mA   |                                |      | -        | -     | V   |
| V <sub>DS</sub> Temperature Coefficient       | $\Delta V_{DS}/T_{J}$                   | Reference  | -                              | 0.70 | -        | V/°C  |     |
| Gate-Source Threshold Voltage (N)             | V <sub>GS(th)</sub>                     | V <sub>DS</sub> =  | $V_{GS}$ , $I_{D} = 250 \mu A$ | 2.0  | -        | 4.0   | V   |
| Gate-Source Leakage                           | I <sub>GSS</sub>                        | \  | $I_{GS} = \pm 20 \text{ V}$    | -    | -        | ± 100 | nA  |
| Zero Gate Voltage Drain Current               | I <sub>DSS</sub>                        | V <sub>DS</sub> = V <sub>DS</sub> = 600 V  | -                              | -    | 1 100    | μΑ    |     |
| Drain-Source On-State Resistance              | R <sub>DS(on)</sub>                     | $V_{GS} = 10 \text{ V}$  | I <sub>D</sub> = 22 A          | _    | 0.160    | 0.190 | Ω   |
| Forward Transconductance <sup>a</sup>         | 9fs                                     | $V_{GS} = 10 \text{ V}$ $I_D = 22 \text{ A}$ $V_{DS} = 50 \text{ V}, I_D = 13 \text{ A}$             |                                | _    | 9.4      | -     | S   |
| Dynamic                                       | 915                                     | 1 03   |                                |      | <u> </u> |       |     |
| Input Capacitance                             | C <sub>iss</sub>                        | $V_{GS} = 0 \text{ V},$<br>$V_{DS} = 25 \text{ V},$<br>f = 1.0  MHz                                  |                                |      | 2810     | -     | pF  |
| Output Capacitance                            | Coss                                    |  |                                | -    | 1480     | -     |     |
| Reverse Transfer Capacitance                  | C <sub>rss</sub>                        |  |                                | -    | 33       | -     |     |
| Effective Output Capacitance (Time Related)   | C <sub>oss eff.</sub> (TR) <sup>a</sup> | V <sub>GS</sub> = 0 V  | V <sub>DS</sub> = 0 V to 480 V | -    | 155      | -     |     |
| Total Gate Charge                             | Qq                                      |  |                                | -    | 75       | -     |     |
| Gate-Source Charge                            | Q <sub>gs</sub>                         | $V_{GS} = 10 \text{ V}$ $I_{D} = 22 \text{ A}, V_{DS} = 480 \text{ V}$                               |                                | -    | 17       | -     | nC  |
| Gate-Drain Charge                             | Q <sub>gd</sub>                         |  |                                |      | 25       | -     |     |
| Turn-On Delay Time                            | t <sub>d(on)</sub>                      | $V_{DD} = 380 \text{ V}, I_D = 22 \text{ A},$ $R_g = 9.1 \Omega, V_{GS} = 10 \text{ V}$              |                                | -    | 24       | -     | ns  |
| Rise Time                                     | t <sub>r</sub>                          |  |                                | -    | 68       | -     |     |
| Turn-Off Delay Time                           | t <sub>d(off)</sub>                     |  |                                |      | 77       | -     |     |
| Fall Time                                     | t <sub>f</sub>                          |  |                                | -    | 59       | -     |     |
| Gate Input Resistance                         | $R_g$                                   | f = 1 MHz, open drain  |                                | -    | 0.65     | -     | Ω   |
| <b>Drain-Source Body Diode Characteristic</b> | es                                      |  |                                |      |          |       |     |
| Continuous Source-Drain Diode Current         | I <sub>S</sub>                          | MOSFET symbol showing the integral reverse p - n junction diode                                      |                                | -    | -        | 22    | _   |
| Pulsed Diode Forward Current                  | I <sub>SM</sub>                         |  |                                | -    | -        | 88    | - A |
| Diode Forward Voltage                         | $V_{SD}$                                | T <sub>J</sub> = 25 °C, I <sub>S</sub> = 22 A, V <sub>GS</sub> = 0 V                                 |                                | -    | -        | 1.2   | V   |
| Reverse Recovery Time                         | t <sub>rr</sub>                         | T <sub>J</sub> = 25 °C, I <sub>F</sub> = I <sub>S</sub> ,<br>dI/dt = 100 A/μs, V <sub>R</sub> = 25 V |                                | -    | 462      | -     | ns  |
| Reverse Recovery Charge                       | Q <sub>rr</sub>                         |  |                                | -    | 8.3      | -     | μC  |
| Reverse Recovery Current                      | I <sub>RRM</sub>                        |  |                                | -    | 30       | -     | Α   |

### Note

a.  $C_{oss\ eff.}$  (TR) is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DS}$ .



### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

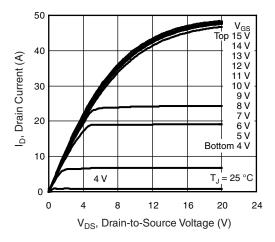


Fig. 1 - Typical Output Characteristics,  $T_J$  = 25 °C

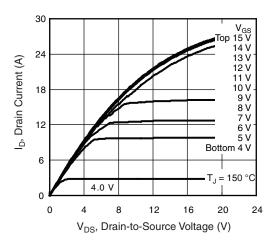


Fig. 2 - Typical Output Characteristics, T<sub>J</sub> = 150 °C

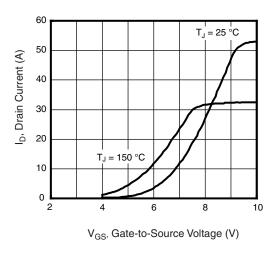


Fig. 3 - Typical Transfer Characteristics

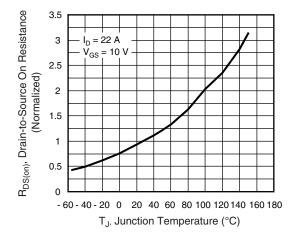
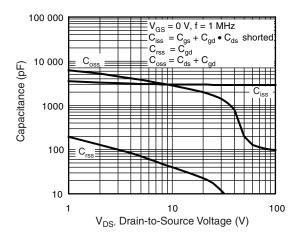


Fig. 4 - Normalized On-Resistance vs. Temperature

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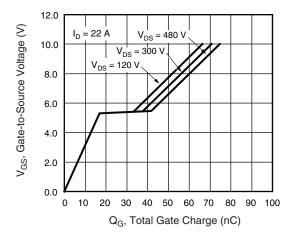




1000 I<sub>SD</sub>, Reverse Drain Current (A) 100 10 T<sub>.1</sub> = 150 °C 0.1 0.01 0.001  $V_{GS} = 0 V$ 0.0001 0.2 0.4 0.6 1.2 8.0 1.4  $V_{SD}$ , Source-to-Drain Voltage (V)

Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

Fig. 7 - Typical Source-Drain Diode Forward Voltage



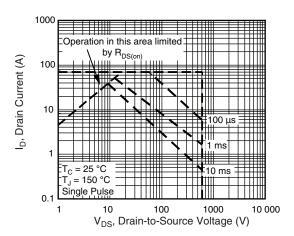


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

Fig. 8 - Maximum Safe Operating Area



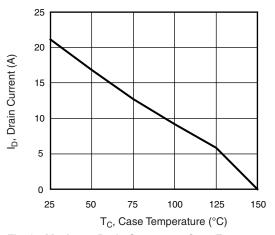


Fig. 9 - Maximum Drain Current vs. Case Temperature

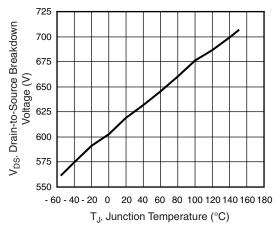


Fig. 10 - Drain-to-Source Breakdown Voltage

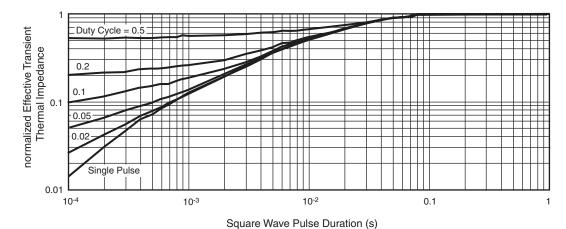


Fig. 11 - Normalized Thermal Transient Impedance, Junction-to-Case

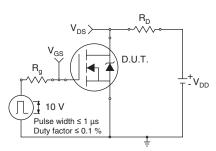


Fig. 11a - Switching Time Test Circuit

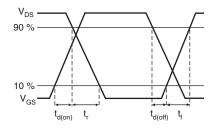


Fig. 11b - Switching Time Waveforms

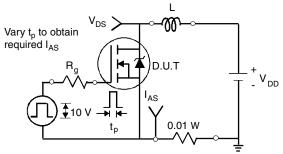


Fig. 12a - Unclamped Inductive Test Circuit

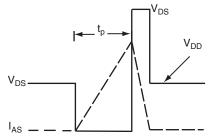


Fig. 12b - Unclamped Inductive Waveforms

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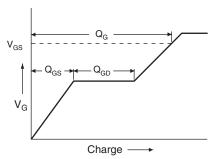


Fig. 13a - Basic Gate Charge Waveform

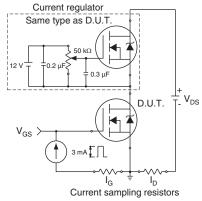
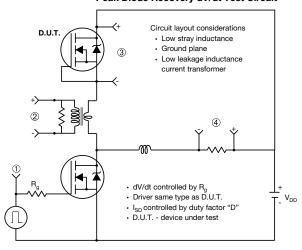


Fig. 13b - Gate Charge Test Circuit

#### Peak Diode Recovery dV/dt Test Circuit



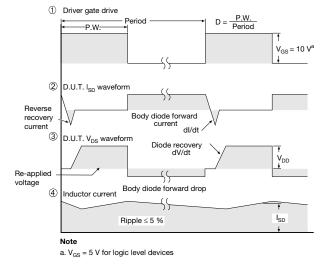


Fig. 14 - For N-Channel

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